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Application/Control No.	Applicant(s)/Patent under Reexamination
10/698,892	TAM ET AL.
Examiner	Art Unit
Hien Nauven	2816

Hiep Nguyen 2816																		
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HIEP NGUYEN 12.21. 05 TOTAL Claims Allowed: 17 (Assistant Examiner) (Date)																		
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